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PTO/SB/05 (4/98)

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UTILITY PATENT APPLICATION TRANSMITTAL		Attorney Docket No. 1301(SURA)
		First Inventor or Application Identifier Gupta and Myneni
		Title Solid Diamond Field Emitter
		Express Mail Label No. EJ845378655US

APPLICATION ELEMENTS <small>See MPEP chapter 600 concerning utility patent application contents.</small>		ADDRESS TO: Assistant Commissioner for Patents Box Patent Application Washington DC 20231	
<p>1. <input checked="" type="checkbox"/> * Fee Transmittal Form (e.g., PTO/SB/17) (Submit an original and a duplicate for fee processing)</p> <p>2. <input checked="" type="checkbox"/> Specification [Total Pages 13] (preferred arrangement set forth below)</p> <ul style="list-style-type: none"> - Descriptive title of the Invention - Cross References to Related Applications - Statement Regarding Fed sponsored R & D - Reference to Microfiche Appendix - Background of the Invention - Brief Summary of the Invention - Brief Description of the Drawings (if filed) - Detailed Description - Claim(s) - Abstract of the Disclosure <p>3. <input checked="" type="checkbox"/> Drawing(s) (35 U.S.C. 113) [Total Sheets 2]</p> <p>4. Oath or Declaration [Total Pages 2]</p> <ul style="list-style-type: none"> a. <input checked="" type="checkbox"/> Newly executed (original or copy) b. <input type="checkbox"/> Copy from a prior application (37 C.F.R. § 1.63(d)) (for continuation/divisional with Box 16 completed) <ul style="list-style-type: none"> i. <input type="checkbox"/> DELETION OF INVENTOR(S) Signed statement attached deleting inventor(s) named in the prior application, see 37 C.F.R. §§ 1.63(d)(2) and 1.33(b). 		<p>5. <input type="checkbox"/> Microfiche Computer Program (Appendix)</p> <p>6. Nucleotide and/or Amino Acid Sequence Submission (if applicable, all necessary)</p> <ul style="list-style-type: none"> a. <input type="checkbox"/> Computer Readable Copy b. <input type="checkbox"/> Paper Copy (identical to computer copy) c. <input type="checkbox"/> Statement verifying identity of above copies 	
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<p>7. <input type="checkbox"/> Assignment Papers (cover sheet & document(s))</p> <p>8. <input type="checkbox"/> 37 C.F.R. §3.73(b) Statement <input checked="" type="checkbox"/> Power of (when there is an assignee) <input checked="" type="checkbox"/> Attorney</p> <p>9. <input type="checkbox"/> English Translation Document (if applicable)</p> <p>10. <input type="checkbox"/> Information Disclosure Statement (IDS)/PTO-1449 <input type="checkbox"/> Copies of IDS Citations</p> <p>11. <input type="checkbox"/> Preliminary Amendment</p> <p>12. <input checked="" type="checkbox"/> Return Receipt Postcard (MPEP 503) (Should be specifically itemized)</p> <ul style="list-style-type: none"> * Small Entity Statement(s) <input type="checkbox"/> Statement filed in prior application, (PTO/SB/09-12) <input type="checkbox"/> Status still proper and desired 13. <input checked="" type="checkbox"/> Certified Copy of Priority Document(s) (if foreign priority is claimed) 14. <input type="checkbox"/> Other: _____ 15. <input type="checkbox"/> Other: _____ 			

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16. If a CONTINUING APPLICATION, check appropriate box, and supply the requisite information below and in a preliminary amendment:

Continuation Divisional Continuation-in-part (CIP) of prior application No: _____ / _____

Prior application information: Examiner _____ Group / Art Unit: _____

For CONTINUATION or DIVISIONAL APPS only: The entire disclosure of the prior application, from which an oath or declaration is supplied under Box 4b, is considered a part of the disclosure of the accompanying continuation or divisional application and is hereby incorporated by reference. The incorporation can only be relied upon when a portion has been inadvertently omitted from the submitted application parts.

17. CORRESPONDENCE ADDRESS

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Date	10/25/99		

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ATTORNEY DOCKET NO. 1301(SURA)

PATENT

Applicant or Patentee: **Mool Chand Gupta and Ganapati Rao Myneni**

Serial or Patent No.:

Filed or Issued:

For: **Solid Diamond Field Emitter**

**VERIFIED STATEMENT (DECLARATION) CLAIMING SMALL ENTITY
STATUS (37 CFR 1.9(f) AND 1.27(c))--INDEPENDENT INVENTOR**

As a below name inventor, I/we hereby declare that I/we qualify as an independent inventor as defined in 37 CFR 1.9(c) for purposes of paying reduced fees under Section 41(a) and (b) of Title 35, United States Code, to the Patent and Trademark Office with regard to the invention entitled **Solid Diamond Field Emitter** described in

X the specification filed herewith.

 application identified above

 patent identified above

I/we have not assigned, granted, conveyed or licensed and am/are under no obligation under contract or law to assign, grant, convey or license, any rights in the invention to any person who could not be classified as an independent inventor under 37 CFR 1.9(c) if that person had made the invention, or to any concern which would not qualify as a small business concern under 37 CFR 1.9(d) or a nonprofit organization under 37 CFR 1.9(e).

Each person, concern or organization to which I/we have assigned, granted, conveyed, or licensed or am/are under an obligation under contract or law to assign, grant, convey, or license any rights in the invention is listed below:

- X no such person, concern, or organization
 persons, concerns or organizations listed below*
- *NOTE: Separate verified statements are required from each named person, concern

or organization having rights to the invention averring to their status as small entities. (37 CFR 1.27).

FULL NAME OF CONCERN:

INDIVIDUAL SMALL BUSINESS CONCERN NONPROFIT ORGANIZATION

I /we acknowledge the duty to file, in this application or patent, notification of any change in status resulting in loss of entitlement to small entity status prior to paying, or at the time of paying, the earliest of the issue fee or any maintenance fee due after the date on which status as a small business entity is no longer appropriate. (37 CFR 1.28(b)).

I/we hereby declare that all statements made herein of my/our own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code, and that such wilful false statements may jeopardize the validity of the application, any patent issuing thereon, or any patent to which this verified statement is directed.

M.C.Gupta
Mool Chand Gupta

DATE 10/19/99

M.R.Myneni
Ganapati Rao Myneni

DATE 10/21/99

Solid Diamond Field Emitter

Field of the Invention

5 The present invention relates to field emitter electron sources for use in
ultra-high vacuum (UHV) and extremely high vacuum (XHV) instrumentation, and
more particularly to diamond based such emitters.

Background of the Invention

10 Present day Ultra High Vacuum and Extremely High Vacuum instrumentation is based primarily on thermoionic electron sources. These sources operate at very high temperatures and consequently, tend to desorb gases from the walls of the vacuum chamber and instrumentation thereby affecting the pressure 15 one is trying to measure. Additionally, at the normal operating current of about 1 mA, they also affect the pressure measurement due to electron stimulated desorption of gases from the vacuum walls as well as the elements of the instruments.

Several attempts have been made to substitute field emitter array cold electron sources for the thermoionic electron sources. However, these field emitters

have relatively large surface areas and create problems due to continuous outgassing.

Cold-cathode electron field emitters using diamonds have been suggested in 5 the prior art because of the negative electron affinity of their surfaces, but these emitters are generally based on thin films of diamonds (less than about 5μ) or alternatively, thin layers of diamond particles embedded in a coating material. While these have often provided improved emitters, the density of their emission fields is often hard to control and not sufficient to provide optimum performance 10 for vacuum instrumentation. Additionally, in the case of bonded diamond particles, the coating is a source of additional measurement interference.

Summary of the Invention

15 According to the present invention there is provided a "solid" diamond i.e. greater than 5μ thick, electron emitter that has been "machined" using non-contact techniques to a point having a radius of less than about 100μ , preferably below about 10μ , and most preferably between about 3 tenths of an angstrom and about 3μ . The solid diamond electron emitters of the present invention can perform, even 20 at these small radii, as multi-point emitters depending upon the radius and roughness of the pointed tip. The emitters of the present invention can be used in arrays of individual emitters to obtain relatively large area emitter fields for applications where such fields are necessary. Production of the solid diamond

emitters of the present invention is preferably accomplished using non-contact electron or ion beam or laser machining techniques.

Residual gas analyzers (RGA), field emitter extractor gauge analyzers
5 (FERGA), Faraday cup detectors and other high and ultra high vacuum devices
utilizing the solid diamond emitters of the present invention as well as free electron
lasers and Linacs that use the technology described herein are also possible.

Description of the Drawings

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Figures 1-3 depict individual steps in the solid diamond fabrication process
described herein.

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Figure 4 is a schematic diagram of the final or finishing step of the
manufacturing process used to fabricate the solid diamond electron emitters of the
present invention.

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Figure 5 is a schematic diagram of a field emitter extractor gauge (FEG)
capable of utilizing an array of the solid diamond emitters of the present invention.

Figure 6 is a schematic diagram of a field emitter residual gas analyzer
(FERGA) capable of utilizing an array of the solid diamond emitters of the present
invention.

Detailed Description

The development of instrumentation useful in extremely high vacuum environments that do not cause measurement disruptive releases of adsorbed gases has been a perplexing problem. Since most such prior art devices rely of thermoionic electron emitters the release of the interfering gases is an inherent property of the emission process. As described above, attempts to solve the problem using cold field emitters have proven largely similarly ineffective due to the relatively large surface areas of such emitters that also desorb gases. The use of thin films of diamonds ($< 5\mu$) or diamond chips embedded in a suitable matrix has also proven of limited effectiveness.

It has now been discovered that the use of single or arrays of "solid" diamond emitters obviate the interference/disturbance problems indicated with prior art systems. According to the present invention there is provided a "solid" diamond i.e. greater than 5μ thick, emitter that has been "machined" using non-contact techniques to a point having a radius of less than about 10μ and preferably between about 5 and about 10 angstroms.

20

As shown in Figures 1-3, preparation of the solid diamond field emitters of the present invention first involves (Fig. 1) selection of a raw diamond 10 having octahedrons at a level of between about 700-900 per carat or between about 0.5 and

0.6mm in size. The raw diamond should be free of flaws, inclusions, free carbon, and cracks and demonstrate a good octahedral shape.

The raw diamond 10 is then sawed in the (001) or cube plane as shown in

5 Figure 2.

The sawed diamond 10 is then mounted on a suitable steel shank 12 (Fig. 3) using a titanium-based “adhesive” 14 applied using well known and conventional techniques under high vacuum. A CuAgTi alloy is preferred as the “adhesive” 10 material. Alternatively, electron beam deposited palladium and titanium metals form adherent coatings on diamond surfaces and can be used to adhere diamond 10 to shank 12.

“Machining” is accomplished as shown in Figure 4. Sawed diamond 10, 15 mounted on steel shank 12 via “adhesive” layer 14 is angularly rotated, preferably at a 30° angle, as required in ion beam 16 to achieve the desired shape described below. An electron beam that incorporates no ions could also be used to etch diamond 10 in the manner described. Ion beam 16 is similar to that used in transmission electron microscopy for purposes of preparing samples under examination. If an electron beam is used, conventional such beams that are known 20 to etch diamond are satisfactory. An ion gun of the type supplied by Commonwealth Scientific Corporation has been found suitable for this application.

Because of the thickness of the tip of diamond 10 in its final form, described below, mechanical methods cannot be used to achieve the polishing or shaping of diamond 10 since the mechanical pressures applied will result in breakage of diamond 10. Thus, some non-contact "machining" means such as ion or electron beam must be used. The use of lasers as non-contact machining tools is generally impossible in this application due to the thermal shock imparted to diamond 10 in such a laser machining process. Laser machining using femtosecond or picosecond pulses may, however, be possible since at these short pulse widths, heating or thermal shock is not as much of a problem. Chemical etching techniques are of course not useful because of the inertness of diamond.

In the practical instrumentation applications of the solid diamond field emitters of the present invention it is desirable to have large field emission currents on the order of milliamperes and low voltage. To fulfill these requirements, the material tip should be very sharp. In order to obtain such a sharp tip, preferably on the order of from about 3 angstroms up to about 100 μ , and preferably from about 5 angstroms up to about 10 μ , and most preferably, as in the case of high current instruments operating in the range of 100 volts, from about 3 angstroms up to about 3 μ , diamond 10 is manipulated in ion or electron beam 16 using conventional manipulation techniques to achieve the desired tip radius.

Since even with fine radii of the dimensions just described, the surface of diamond 10 after ion or electron beam machining will not be perfectly smooth, a

single solid diamond tip of the type described herein may act as an array of tips depending upon the surface roughness of the tip. For the larger radii tips a surface roughness (peak height) of between about 20 angstroms and about 1μ is preferred. Most preferred, however, is a surface roughness of less than about 10 angstroms for
5 those applications wherein single point electron field emission is desired.

The shape of the solid diamond tip is not particularly critical, i.e. it can be a wide cone, a narrow cone or even an asymmetric shape, so long as some portion of its extreme surface is pointed within the radius parameters just described.

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Where a wide field emission is required, a plurality of the solid diamond emitters of the present invention can be arrayed to provide whatever breadth of electron field is desired. Indeed, the appropriate surface roughness, as just described, may provide a sufficient number of diamond points to provide a broader
15 field of electron emission than would be achieved with a "smoother" solid diamond surface. Arrays of the emitters of the present invention that include the pointed solid diamond electron emitter mounted or adhered to an appropriate conductive shank as described above are useful in many types of instrumentation.

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Figure 5 schematically depicts a field emitter extractor gauge (FEG) of the type in which the solid diamond emitter of the present is useful. As shown in Figure 5, FEG 20 comprises field emitter 22 or 24. In the case of field emitter 22, the device is called a Top FEG while in the case where field emitter 24 is present the device is

called a Side FEG. Anode grid 26 surrounds the volume 28 and serves to direct the flow of electrons from either field emitter 22 or field emitter 24 toward focus plate 30 having aperture 32 therein. Reflector 34 reflects electrons passing through aperture 32 at an obtuse angle back toward focus plate 30. Aperture 36 in reflector 5 34 allows passage of a focused electron beam to collector 38. Arrays of the solid diamond emitters of the present invention are useful as either the top or side FEG configurations.

Figure 6 depicts schematically a field emitter residual gas analyzer (FERGA) 10 that can utilize the solid diamond field emitters of the present invention. As shown in Figure 6, the FERGA 40 comprises: 1) a field emitter array 42 that can be a solid diamond field emitter or an array of such emitters of the type described herein; an anode grid 44 enclosing volume 46 to direct electrons from field emitter array 42; a focus plate 50 having aperture 52 therein that permits passage of a focused electron 15 beam through focus plate 50, and quadrupole 54.

As the invention has been described, it will be apparent to those skilled in the art that the same may be varied in many ways without departing from the spirit and scope of the invention. Any and all such modifications are intended to be included 20 within the scope of the appended claims.

What is claimed is:

- 1) A solid diamond electron emitter comprising a diamond greater than 5μ in thickness having a pointed surface with a radius of less than about 100μ .
5
- 2) The solid diamond electron emitter of claim 1 wherein said radius is less than about 10μ .
- 10 3) The solid diamond electron emitter of claim 2 wherein said radius ranges from about 3 angstroms to about 3μ .
- 15 4) The solid diamond electron emitter of claim 2 wherein said point has a surface roughness of between about 20 angstroms and about 10μ .
- 5) The solid diamond electron emitter of claim 2 wherein said point has a surface roughness below about 10 angstroms.
- 20 6) The solid diamond electron emitter of claim 1 wherein said point is produced using a non-contact machining technique.

- 7) The solid diamond electron emitter of claim 4 wherein said non-contact machining technique is selected from the group consisting of electron beam, ion beam and laser machining techniques.

5

- 8) The solid diamond electron emitter of claim 5 wherein said radius is less than about 10 μ .

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- 9) The solid diamond electron emitter of claim 5 wherein said radius ranges from about 3 angstroms to about 3 μ .

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- 10) The solid diamond electron emitter of claim 1 further including a conductive shank to which said diamond is adhered.

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- 11) The solid diamond electron emitter of claim 9 wherein said diamond is adhered to said conductive shank by a vapor deposited layer of palladium or titanium.

- 12) The solid diamond field emitter of claim 10 wherein said radius is less than about 10 μ .

- 5
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- 13) The solid diamond electron emitter of claim 10 wherein said radius ranges from about 3 angstroms to about 3μ .
- 14) The solid diamond electron field emitter of claim 9 wherein said point is produced using a non-contact machining technique.
- 15) The solid diamond electron emitter of claim 13 wherein said non-contact machining technique is selected from the group consisting of electron beam, ion beam and laser machining techniques.
- 16) A field emitter extractor gauge comprising a field emitter array, an anode grid, a focus plate, a reflector and a collector wherein said field emitter array comprises an array of solid diamond electron emitters each comprising a diamond greater than 5μ in thickness having a pointed surface with a radius of less than about 100μ .
- 17) A residual gas analyzer comprising a field emitter array, an anode grid, a focus plate and a quadrupole wherein said field emitter array comprises an array of solid diamond electron

emitters each comprising a diamond greater than 5μ in thickness having a pointed surface with a radius of less than about 100μ .

Abstract

The present invention provides a "solid" diamond, i.e. greater than 5μ thick, electron emitter that has been "machined" using non-contact techniques to a point
5 having a radius of less than about 100μ , preferably below about 10μ and most preferably between about 3 angstroms and about 3μ . The solid diamond electron emitters of the present invention can perform, even at these small radii, as multi-point emitters depending upon the radius and roughness of the pointed tip and can be used in arrays to obtain relatively large area field emitters for applications where
10 such larger field emissions are necessary. Production of the solid diamond emitters of the present invention is preferably accomplished using non-contact electron or ion beam machining techniques. Residual gas analyzers (RGA) and field emitter extractor gauge analyzers (FERGA) that use the solid diamond emitters are also described.

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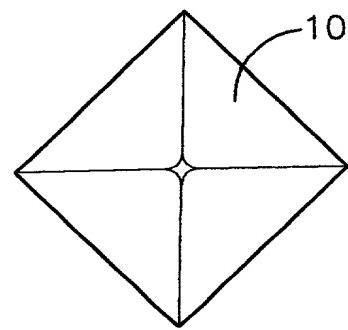


FIG. 1

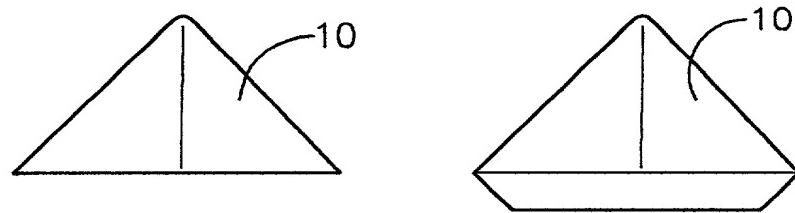


FIG. 2

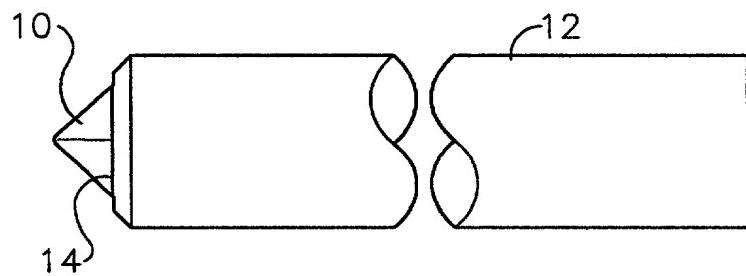


FIG. 3

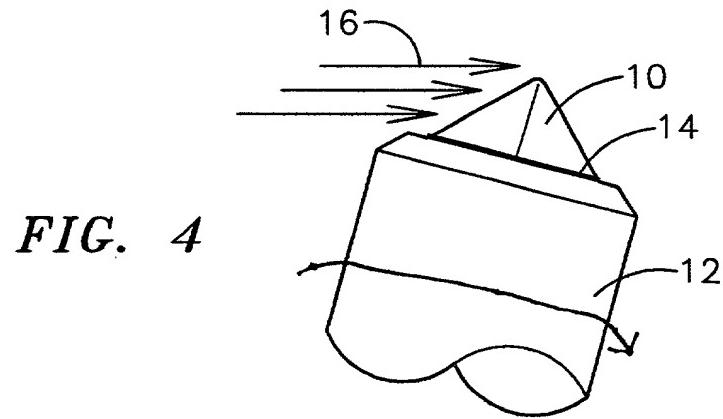


FIG. 4

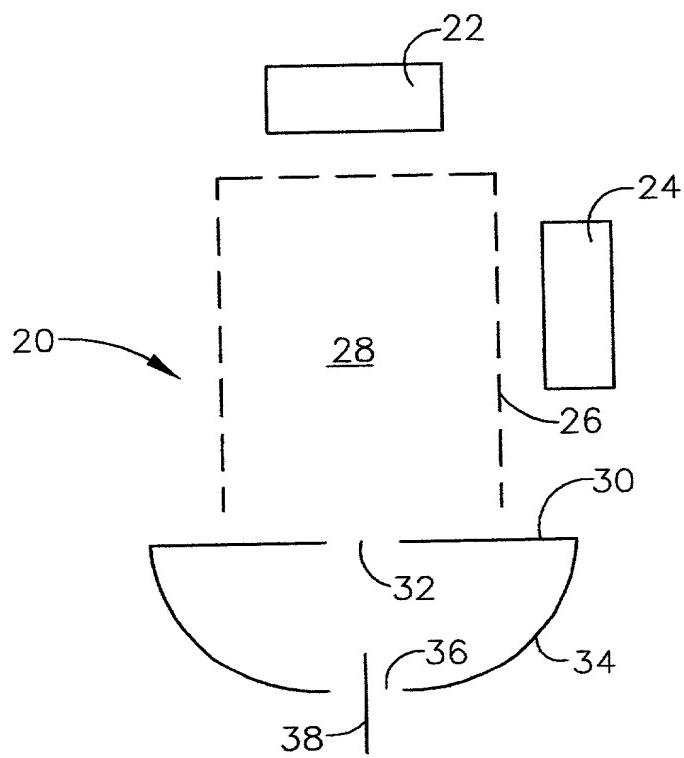


FIG. 5

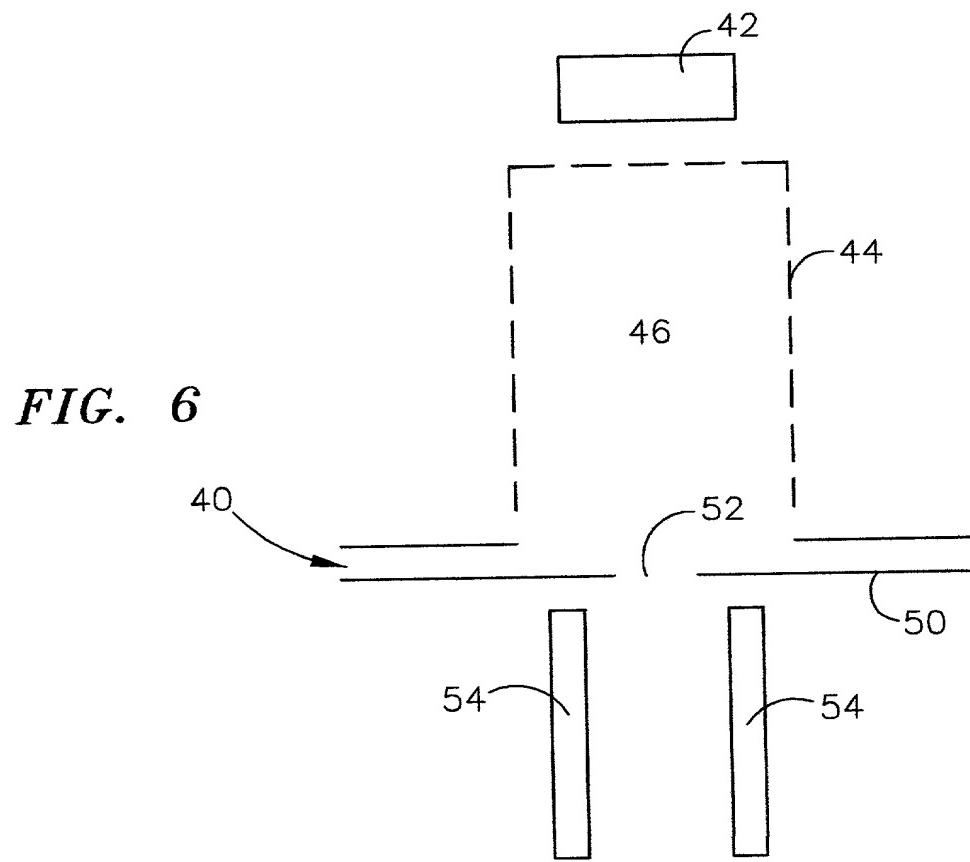


FIG. 6

**UNITED STATES
COMBINED DECLARATION AND POWER OF ATTORNEY**

As a below named inventor, I hereby declare that: My residence, post office address and citizenship are as stated below next to my name, I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled: **Solid Diamond Field Emitter**, the application of which is attached hereto.

I hereby state that I have reviewed and understand the contents of the above identified specification, including the claims, as amended by any amendment referred to above. I acknowledge the duty to disclose to the Office all information known to me which is material to the examination of this application as defined in §1.56. I hereby claim foreign priority benefits under Title 35, United States Code, § 119 of any foreign application(s) for patent or inventor's certificate or of any PCT international application(s) designating at least one country other than the United States of America listed below and have also identified below any foreign application(s) for patent or inventors certificate or any PCT international application(s) designating at least one country other than the United States of America filed by me on the same subject matter having a filing date before that of the application(s) of which priority is claimed.

Prior Foreign Application(s)

Prior Claim

(Number)	(Country)	(Day/Month/Year Filed)	[]	[]
			Yes	No
(Number)	(Country)	(Day/Month/Year Filed)	[]	[]
			Yes	No

I hereby claim the benefit under Title 35, United States Code, § 120 of any United States application listed below and insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application(s) in the manner provided by the first paragraph of Title 35, United States Code, § 112. I acknowledge the duty to disclose to the Office all information known to me which is material to the examination of this application as defined in §1.56 which became available between the filing date of the prior application and the national or PCT international filing date of this application.

(Application Serial No)	(Filing Date)	(Status: patented, pending, abandoned)
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(Application Serial No)	(Filing Date)	(Status: patented, pending, abandoned)
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As a named inventor, I hereby appoint Auzville Jackson, Jr., Reg. No. 17,306, as my attorney to prosecute this application, and transact all business in the Patent and Trademark Office connected therewith and to act on my behalf before the competent International Authorities in connection with any and all international applications filed by me and of which I am the sole applicant and to receive payments on my behalf.

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I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code, and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

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